

Search Notes

Application/Control No.

10/602,462

Examiner

Tianjie Chen

Applicant(s)/Patent under
Reexamination

BEDELL ET AL.

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
360	126		
	317	2/12/2008	TJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
360	126		
360	317	2/12/2008	TJ

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Rep[ort	2/12/2008	TJ